

Notice of References Cited	Application/Control No. 10/763,272	Applicant(s)/Patent Under Reexamination ACCARIE ET AL.	
	Examiner David E. Martinez	Art Unit 2181	Page 1 of 1

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*	B	US-2003/0078072 A1	04-2003	Serceki et al.	455/557
*	C	US-2006/0007933 A1	01-2006	Maxson et al.	370/392
*	D	US-2003/0028887 A1	02-2003	Frouin et al.	725/78
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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